

- ☐ Home
- ☐ What Can I Access?
- ☐ Log-out

## Tables of Contents

- ☐ Journals & Magazines
- ☐ Conference Proceedings
- ☐ Standards

## Search

- ☐ By Author
- ☐ Basic
- ☐ Advanced

## Member Services

- ☐ Join IEEE
- ☐ Establish IEEE Web Account

Your search matched **3** of **784832** documents.  
Results are shown **15** to a page, sorted by **publication year** in **descending** order.  
You may refine your search by editing the current search expression or entering a new one the text box.

Then click **Search Again**.

employer\* and employee\* and compar\*

Search Again

## Results:

Journal or Magazine = **JNL** Conference = **CNF** Standard = **STD**

### 1 Information-theoretic feature selection for a neural behavioral model

*Chambless, B.; Scarborough, D.*

Neural Networks, 2001. Proceedings. IJCNN '01. International Joint Conference on , Volume: 2 , 2001

Page(s): 1443 -1448 vol.2

[\[Abstract\]](#) [\[PDF Full-Text \(492 KB\)\]](#) **CNF**

### 2 Evaluation of skill requirements in contract electronics manufacture

*Salt, C.; Leicester, G.; Jones, R.*

Education and Training for the Electronics Manufacturing Industry (Ref. No: 1997/084), IEE Colloquium on , 1997

Page(s): 5/1 -5/9

[\[Abstract\]](#) [\[PDF Full-Text \(632 KB\)\]](#) **CNF**

### 3 Creating a national system for vocational standards and qualifications

*Thompson, P.J.*

Science, Measurement and Technology, IEE Proceedings A , Volume: 137 Issue: 5 , Sept. 1990

Page(s): 309 -312

[\[Abstract\]](#) [\[PDF Full-Text \(376 KB\)\]](#) **JNL**

[Home](#) | [Log-out](#) | [Journals](#) | [Conference Proceedings](#) | [Standards](#) | [Search by Author](#) | [Basic Search](#) | [Advanced Search](#)  
[Join IEEE](#) | [Web Account](#) | [New this week](#) | [OPAC Linking Information](#) | [Your Feedback](#) | [Technical Support](#) | [Email Alerting](#)  
[No Robots Please](#) | [Release Notes](#) | [IEEE Online Publications](#) | [Help](#) | [FAQ](#) | [Terms](#) | [Back to Top](#)

Copyright © 2002 IEEE — All rights reserved